

Search Notes

Application/Control No.

10/740,033

Examiner

Phallaka Kik

Applicant(s)/Patent under
Reexamination

CERNY ET AL.

Art Unit

2825

SEARCHED

Class	Subclass	Date	Examiner
716	5,3,18	2/1/2006	PK
703	16, 17	2/1/2006	PK
714	741,33	2/1/2006	PK
324	750	2/1/2006	PK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
716	5,3,18	2/2/2006	PK
703	16	2/2/2006	PK
--USPGPUB (see attached)		2/2/2006	PK

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
BRS (EAST) --USPAT, USPGPUB Cls/sub searched: 716/1-18; 703/2, 13-22; 714/32- 57,733,734,741; 324/537-769 (see attached)	2/1/2006	PK
--EPO, JPO, IBM TDB, Derwent (see attached)	2/1/2006	PK
IEE/IEEE Xplore (see attached)	2/1/2006	PK
Consulted with Examiner Vuthe Siek --allowable subject matter	2/2/2006	PK
Consulted with Examiner James C. Kerveros --suggested search in 714/741,33; 324/750...but no cross-referencing.	2/3/2006	PK